

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination FUKUDA ET AL.	
		09/939,824	Examiner Joseph Waks	Art Unit 2834

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,027,025	06-1991	Saneshige et al.	310/156.38
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 10108433 A	04-1998	Japan	Toshiba-Lightech	H02K 29/00
*	O	JP 05103451 A	04-1993	Japan	---	H02K 05/22
*	P	JP 0970162 A	03-1997	Japan	Matsushita Denki	i---
*	Q	JP 10295068 A	11-1998	Japan	Sankyo Seiki	H02K 05/22
*	R	WO 01/43261 A1	06-2001	WIPO	Yoshida et al.	---
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.